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October 2013

FDP038AN06A0 / FDI038AN06A0

N-Channel PowerTrench[®] MOSFET 60 V, 80 A, 3.8 m Ω

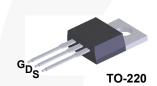
Features

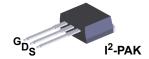
- $R_{DS(on)}$ = 3.5 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 80 A
- $Q_{G(tot)}$ = 96 nC (Typ.) @ V_{GS} = 10 V
- Low Miller Charge
- Low Q_{rr} Body Diode
- UIS Capability (Single Pulse and Repetitive Pulse)

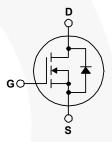
Formerly developmental type 82584

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- · Motor drives and Uninterruptible Power Supplies







MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter	FDP038AN06A0 FDI038AN06A0	Unit
V _{DSS}	Drain to Source Voltage	60	V
$\frac{V_{DSS}}{V_{GS}}$	Gate to Source Voltage	±20	V
I _D	Drain Current		
	Continuous ($T_C < 151^{\circ}C$, $V_{GS} = 10V$)	80	Α
	Continuous ($T_{amb} = 25^{\circ}C$, $V_{GS} = 10V$, with $R_{\theta JA} = 62^{\circ}C/W$)	17	А
	Pulsed	Figure 4	Α
E _{AS}	Single Pulse Avalanche Energy (Note 1)	625	mJ
P _D	Power dissipation	310	W
	Derate above 25°C	2.07	W/°C
T _J , T _{STG}	Operating and Storage Temperature	-55 to 175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.48	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 2)	62	°C/W

l	Package Marking and Ordering Information						
l	Device Marking	Device	Package	Reel Size	Tape Width	Quantity	
l	FDP038AN06A0	FDP038AN06A0	TO-220	Tube	N/A	50 units	
	FDI038AN06A0	FDI038AN06A0	I ² -PAK	Tube	N/A	50 units	

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Chara	octeristics					
B _{VDSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
	Zone Onto Vallana Brain Oursell	V _{DS} = 50V	-	-	1	^
I _{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ $T_C = 150^{\circ}C$	-	-	250	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	cteristics					
V _{GS(TH)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2	-	4	V
, ,		I _D = 80A, V _{GS} = 10V	-	0.0035	0.0038	Ω
	Drain to Source On Posistance	$I_D = 40A, V_{GS} = 6V$	-	0.0049	0.0074	
r _{DS(ON)}	Drain to Source On Resistance	$I_D = 80A$, $V_{GS} = 10V$, $T_J = 175$ °C	-	0.0071	0.0078	
Dynamic	Characteristics					
C _{ISS}	Input Capacitance	1	- \	6400	-	pF
C _{OSS}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1MHz	-	1123	-	pF
C _{RSS}	Reverse Transfer Capacitance	I = IMHZ	-	367	-	pF
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 0V \text{ to } 10V$		96	124	nC
$Q_{g(TH)}$	Threshold Gate Charge	$V_{GS} = 0V \text{ to } 2V$ $V_{DD} = 30V$	-	12	15	nC
Q _{qs}	Gate to Source Gate Charge	I _D = 80A	-	26	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau	$I_g = 1.0 \text{mA}$	-	15	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		-	27	-	nC
Switching	g Characteristics (V _{GS} = 10V)					
t _{ON}	Turn-On Time		-/	-	175	ns
t _{d(ON)}	Turn-On Delay Time		/-	17	- /	ns
t _r	Rise Time	$V_{DD} = 30V, I_{D} = 80A$	-	144	-/	ns
t _{d(OFF)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GS} = 2.4\Omega$	-	34	- /-	ns
t _f	Fall Time		-	60	/ -	ns
t _{OFF}	Turn-Off Time		-	- "	115	ns
Drain-Sou	urce Diode Characteristics					
		I _{SD} = 80A	-	1 -	1.25	V
V_{SD}	Source to Drain Diode Voltage	I _{SD} = 40A	_	-	1.0	V
t _{rr}	Reverse Recovery Time	$I_{SD} = 75A$, $dI_{SD}/dt = 100A/\mu s$	-	-	38	ns

Q_{RR}

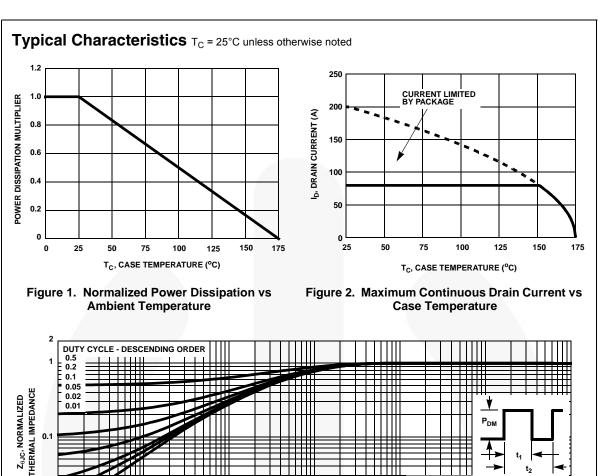
Notes: 1: Starting $T_J = 25^{\circ}C$, L = 0.255mH, $I_{AS} = 70A$. 2: Pulse Width = 100s

Reverse Recovered Charge

 $I_{SD} = 75A$, $dI_{SD}/dt = 100A/\mu s$

39

nC





10⁻³

10⁻²

t, RECTANGULAR PULSE DURATION (s)

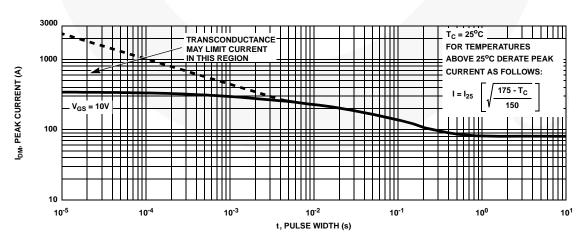


Figure 4. Peak Current Capability

SINGLE PULSE

10-4

0.01 10⁻⁵

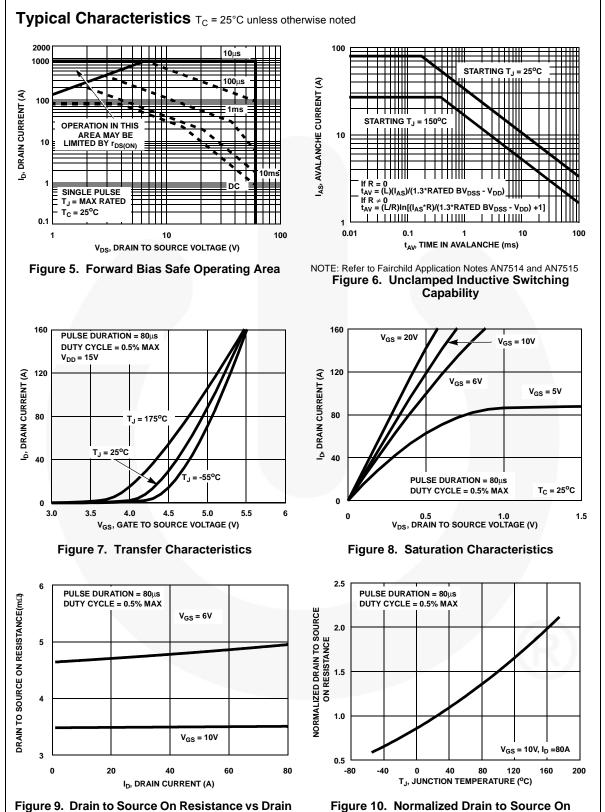
NOTES: DUTY FACTOR: D = t₁/t₂

10⁻¹

PEAK $T_J = P_{DM} x Z_{\theta JC} x R_{\theta JC} + T_C$

10⁰

10¹



Current

Resistance vs Junction Temperature

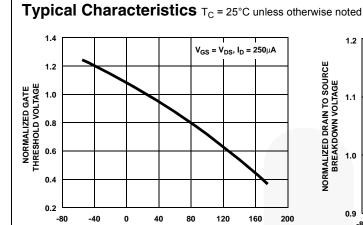


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

T_J, JUNCTION TEMPERATURE (°C)

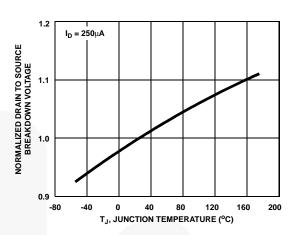


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

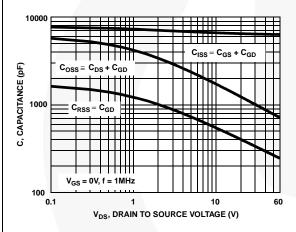


Figure 13. Capacitance vs Drain to Source Voltage

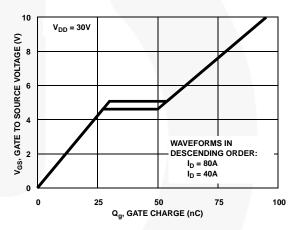


Figure 14. Gate Charge Waveforms for Constant Gate Current

Test Circuits and Waveforms

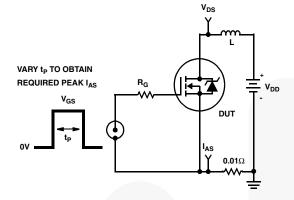


Figure 15. Unclamped Energy Test Circuit

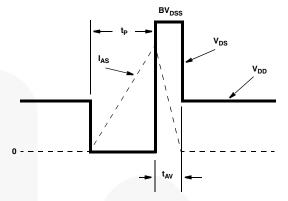


Figure 16. Unclamped Energy Waveforms

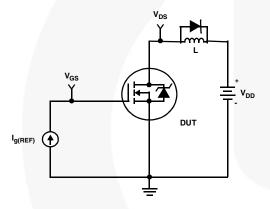


Figure 17. Gate Charge Test Circuit

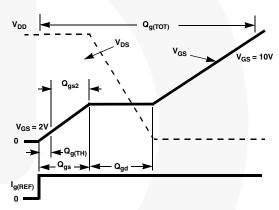


Figure 18. Gate Charge Waveforms

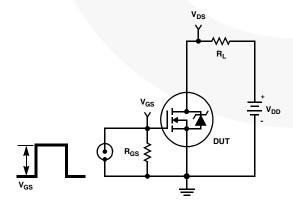


Figure 19. Switching Time Test Circuit

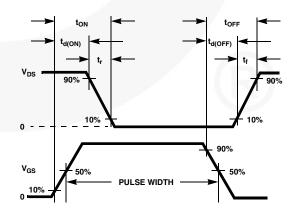
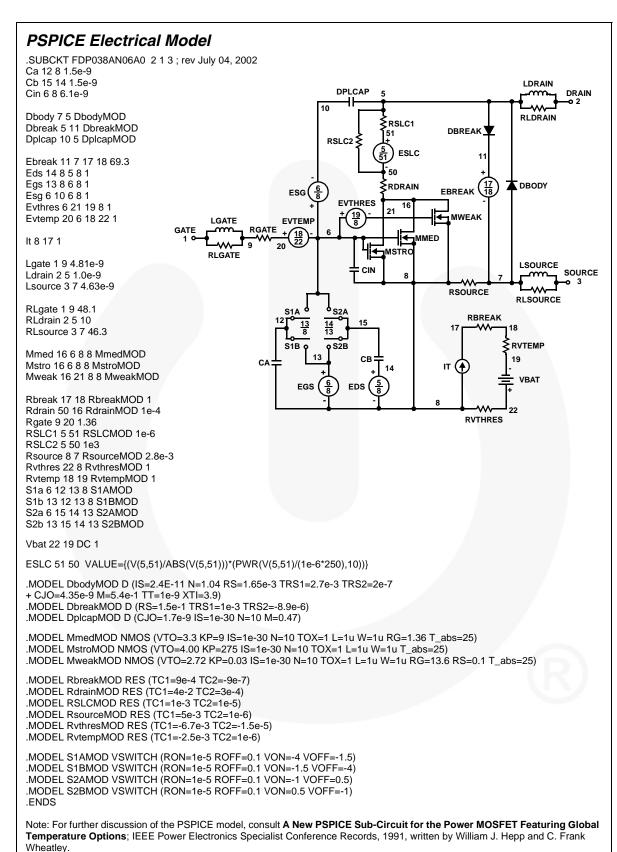


Figure 20. Switching Time Waveforms



SABER Electrical Model rev July 4, 2002 template FDP038AN06A0 n2,n1,n3 = m_temp electrical n2,n1,n3 number m_temp=25 var i iscl dp..model dbodymod = (isl=2.4e-11,nl=1.04,rs=1.65e-3,trs1=2.7e-3,trs2=2e-7,cjo=4.35e-9,m=5.4e-1,tt=1e-9,xti=3.9) dp..model dbreakmod = (rs=1.5e-1,trs1=1e-3,trs2=-8.9e-6) dp..model dplcapmod = (cjo=1.7e-9,isl=10e-30,nl=10,m=0.47) $m..model mmedmod = (type=_n, vto=3.3, kp=9, is=1e-30, tox=1)$ m..model mstrongmod = (type=_n,vto=4.00,kp=275,is=1e-30, tox=1) LDRAIN m..model mweakmod = (type=_n,vto=2.72,kp=0.03,is=1e-30, tox=1,rs=0.6) DRAIN 0 2 sw_vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-4,voff=-1.5) 10 sw_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-1.5,voff=-4) **RLDRAIN** sw_vcsp..model s2amod = (ron=1e-5,roff=0.1,von=-1,voff=0.5) RSLC1 sw_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=0.5,voff=-1) RSLC2 € c.ca n12 n8 = 1.5e-9ISCL c.cb n15 n14 = 1.5e-9c.cin n6 n8 = 6.1e-9DBREAK 50 RDRAIN dp.dbody n7 n5 = model=dbodymod **ESG** ▲ DBODY dp.dbreak n5 n11 = model=dbreakmod **EVTHRES** dp.dplcap n10 n5 = model=dplcapmod (<u>19</u>) MWEAK LGATE **EVTEMP** RGATE spe.ebreak n11 n7 n17 n18 = 69.3 **EBREA** Л MMFD spe.eds n14 n8 n5 n8 = 1 MSTRC RLGATE spe.egs n13 n8 n6 n8 = 1 LSOURCE spe.esg n6 n10 n6 n8 = 1 CIN SOURCE spe.evthres n6 n21 n19 n8 = 1 spe.evtemp n20 n6 n18 n22 = 1 **RSOURCE** RLSOURCE i.it n8 n17 = 1RBREAK 17 18 I.lgate n1 n9 = 4.81e-9**₹**RVTFMP I.Idrain n2 n5 = 1.0e-9СВ I.Isource n3 n7 = 4.63e-919 CA IT res.rlgate n1 n9 = 48.1 **EGS** res.rldrain n2 n5 = 10 res risource n3 n7 = 46.3RVTHRES m.mmed n16 n6 n8 n8 = model=mmedmod, temp=m_temp, l=1u, w=1u m.mstrong n16 n6 n8 n8 = model=mstrongmod, temp=m_temp, l=1u, w=1u m.mweak n16 n21 n8 n8 = model=mweakmod, temp=m_temp, l=1u, w=1u res.rbreak n17 n18 = 1, tc1=9e-4,tc2=-9e-7 res.rdrain n50 n16 = 1e-4, tc1=4e-2,tc2=3e-4 res.rgate n9 n20 = 1.36 res.rslc1 n5 n51 = 1e-6, tc1=1e-3,tc2=1e-5 res.rslc2 n5 n50 = 1e3res.rsource n8 n7 = 2.8e-3, tc1=5e-3,tc2=1e-6 res.rvthres n22 n8 = 1, tc1=-6.7e-3,tc2=-1.5e-5 res.rvtemp n18 n19 = 1, tc1=-2.5e-3,tc2=1e-6 sw vcsp.s1a n6 n12 n13 n8 = model=s1amod sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/250))** 10))

SPICE Thermal Model JUNCTION REV 23 July 4, 2002 FDP038AN06A0T CTHERM1 TH 6 6.45e-3 CTHERM2 6 5 3e-2 CTHERM3 5 4 1.4e-2 RTHERM1 CTHERM4 4 3 1.65e-2 CTHERM1 CTHERM5 3 2 4.85e-2 CTHERM6 2 TL 1e-1 RTHERM1 TH 6 3.24e-3 RTHERM2 6 5 8.08e-3 RTHERM3 5 4 2.28e-2 RTHERM4 4 3 1e-1 RTHERM2 CTHERM2 RTHERM5 3 2 1.1e-1 RTHERM6 2 TL 1.4e-1 SABER Thermal Model RTHERM3 CTHERM3 SABER thermal model FDP035AN06A0T template thermal_model th tl thermal_c th, tl ctherm.ctherm1 th 6 =6.45e-3 ctherm.ctherm2 6 5 =3e-2 ctherm.ctherm3 5 4 =1.4e-2 ctherm.ctherm4 4 3 =1.65e-2 RTHERM4 CTHERM4 ctherm.ctherm5 3 2 =4.85e-2 ctherm.ctherm6 2 tl =1e-1 3 rtherm.rtherm1 th 6 = 3.24e-3 rtherm.rtherm2 6 5 =8.08e-3 rtherm.rtherm3 5 4 =2.28e-2 rtherm.rtherm4 4 3 =1e-1 CTHERM5 RTHERM5 rtherm.rtherm5 3 2 =1.1e-1 rtherm.rtherm6 2 tl=1.4e-1 2 RTHERM6 CTHERM6 CASE

Mechanical Dimensions

TO-220 3L

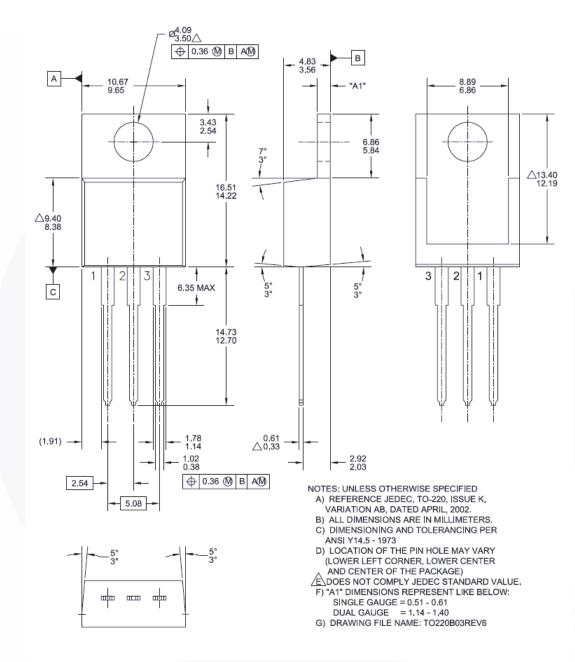


Figure 21. TO-220, Molded, 3Lead, Jedec Variation AB

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Dimension in Millimeters

Mechanical Dimensions

TO-262 3L (I²PAK)

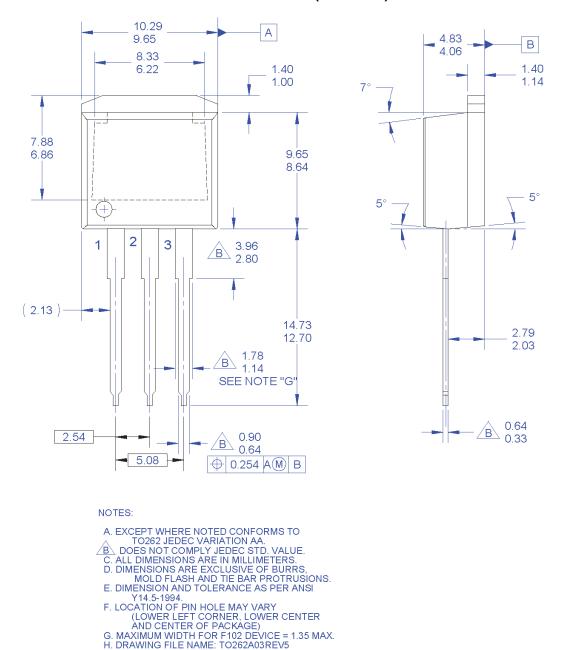


Figure 22. 3LD, TO262, Jedec Variation AA (I²PAK)

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Dimension in Millimeters





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